



RADIO TEST REPORT

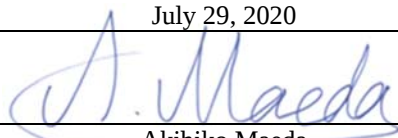
Test Report No. : 13440383H-A-R1

Applicant : NIDEC MOBILITY CORPORATION
Type of EUT : Keyless Operation Key (FOB)
Model Number of EUT : G8D-744M-KEY-N
FCC ID : OUC744M-KEY-N
Test regulation : FCC Part 15 Subpart C: 2020
Test Result : Complied (Refer to SECTION 3.2)

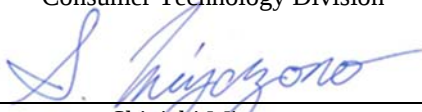
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2. The results in this report apply only to the sample tested.
3. This sample tested is in compliance with the limits of the above regulation.
4. The test results in this test report are traceable to the national or international standards.
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6. This test report covers Radio technical requirements. It does not cover administrative issues such as Manual or non-Radio test related Requirements. (if applicable)
7. The all test items in this test report are conducted by UL Japan, Inc. Ise EMC Lab.
8. The opinions and the interpretations to the result of the description in this report are outside scopes where UL Japan has been accredited.
9. The information provided from the customer for this report is identified in Section 1.
10. This report is a revised version of 13440383H-A. 13440383H-A is replaced with this report.

Date of test: July 29, 2020

Representative test engineer:


Akihiko Maeda
Engineer
Consumer Technology Division

Approved by:


Shinichi Miyazono
Engineer
Consumer Technology Division



CERTIFICATE 5107.02

- ☐ The testing in which "Non-accreditation" is displayed is outside the accreditation scopes in UL Japan.
☒ There is no testing item of "Non-accreditation".

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REVISION HISTORY

Original Test Report No.: 13440383H-A

Revision	Test report No.	Date	Page revised	Contents
- (Original)	13440383H-A	September 1, 2020	-	-
1	13440383H-A-R1	September 23, 2020	P.14	Correction of Sample calculation for Radiated Emission; From “Result of PK with Duty factor = Reading + Ant Factor + Loss {Cable + Attenuator + Filter (above 1 GHz) +Distance factor (above 1 GHz)} - Gain (Amplifier)” To “Result of PK with Duty factor = Reading + Ant Factor + Loss {Cable + Attenuator + Filter (above 1 GHz) +Distance factor (above 1 GHz)} - Gain (Amplifier) + Duty factor”

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Reference: Abbreviations (Including words undescribed in this report)

A2LA	The American Association for Laboratory Accreditation	MCS	Modulation and Coding Scheme
AC	Alternating Current	MRA	Mutual Recognition Arrangement
AFH	Adaptive Frequency Hopping	N/A	Not Applicable
AM	Amplitude Modulation	NIST	National Institute of Standards and Technology
Amp, AMP	Amplifier	NS	No signal detect.
ANSI	American National Standards Institute	NSA	Normalized Site Attenuation
Ant, ANT	Antenna	NVLAP	National Voluntary Laboratory Accreditation Program
AP	Access Point	OBW	Occupied Band Width
ASK	Amplitude Shift Keying	OFDM	Orthogonal Frequency Division Multiplexing
Atten., ATT	Attenuator	P/M	Power meter
AV	Average	PCB	Printed Circuit Board
BPSK	Binary Phase-Shift Keying	PER	Packet Error Rate
BR	Bluetooth Basic Rate	PHY	Physical Layer
BT	Bluetooth	PK	Peak
BT LE	Bluetooth Low Energy	PN	Pseudo random Noise
BW	BandWidth	PRBS	Pseudo-Random Bit Sequence
Cal Int	Calibration Interval	PSD	Power Spectral Density
CCK	Complementary Code Keying	QAM	Quadrature Amplitude Modulation
Ch., CH	Channel	QP	Quasi-Peak
CISPR	Comite International Special des Perturbations Radioelectriques	QPSK	Quadri-Phase Shift Keying
CW	Continuous Wave	RBW	Resolution Band Width
DBPSK	Differential BPSK	RDS	Radio Data System
DC	Direct Current	RE	Radio Equipment
D-factor	Distance factor	RF	Radio Frequency
DFS	Dynamic Frequency Selection	RMS	Root Mean Square
DQPSK	Differential QPSK	RSS	Radio Standards Specifications
DSSS	Direct Sequence Spread Spectrum	Rx	Receiving
EDR	Enhanced Data Rate	SA, S/A	Spectrum Analyzer
EIRP, e.i.r.p.	Equivalent Isotropically Radiated Power	SG	Signal Generator
EMC	ElectroMagnetic Compatibility	SVSWR	Site-Voltage Standing Wave Ratio
EMI	ElectroMagnetic Interference	TR	Test Receiver
EN	European Norm	Tx	Transmitting
ERP, e.r.p.	Effective Radiated Power	VBW	Video BandWidth
EU	European Union	Vert.	Vertical
EUT	Equipment Under Test	WLAN	Wireless LAN
Fac.	Factor		
FCC	Federal Communications Commission		
FHSS	Frequency Hopping Spread Spectrum		
FM	Frequency Modulation		
Freq.	Frequency		
FSK	Frequency Shift Keying		
GFSK	Gaussian Frequency-Shift Keying		
GNSS	Global Navigation Satellite System		
GPS	Global Positioning System		
Hori.	Horizontal		
ICES	Interference-Causing Equipment Standard		
IEC	International Electrotechnical Commission		
IEEE	Institute of Electrical and Electronics Engineers		
IF	Intermediate Frequency		
ILAC	International Laboratory Accreditation Conference		
ISED	Innovation, Science and Economic Development Canada		
ISO	International Organization for Standardization		
JAB	Japan Accreditation Board		
LAN	Local Area Network		
LIMS	Laboratory Information Management System		

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SECTION 1: Customer information

Company Name	:	NIDEC MOBILITY CORPORATION
Address	:	6368, Nenjo-zaka, Okusa, Komaki-city, Aichi 485-802 Japan
Telephone Number	:	+81-568-78-6394
Facsimile Number	:	+81-568-78-6178
Contact Person	:	Yoshiro Murata

The information provided from the customer is as follows;

- Applicant, Type of EUT, Model Number of EUT, FCC ID on the cover and other relevant pages
- Operating/Test Mode(s) (Mode(s)) on all the relevant pages
- SECTION 1: Customer information
- SECTION 2: Equipment under test (EUT) other than the Receipt Date
- SECTION 4: Operation of EUT during testing

* The laboratory is exempted from liability of any test results affected from the above information in SECTION 2 and 4.

SECTION 2: Equipment under test (EUT)

2.1 Identification of EUT

Type	:	Keyless Operation Key (FOB)
Model Number	:	G8D-744M-KEY-N
Serial Number	:	Refer to SECTION 4.2
Rating	:	DC 3.0 V
Receipt Date	:	July 29, 2020
Country of Mass-production	:	Japan
Condition	:	Production prototype (Not for Sale: This sample is equivalent to mass-produced items.)
Modification	:	No Modification by the test lab

2.2 Product Description

Model: G8D-744M-KEY-N (referred to as the EUT in this report) is a Keyless Operation Key (FOB).

Radio Specification

Radio Type	:	Transceiver
Frequency of Operation	:	315 MHz
Clock frequency(maximum)	:	9.84375 MHz (Crystal)
Modulation	:	FSK (F1D)
Type of Battery	:	Lithium battery (CR2032)
Antenna type	:	Pattern antenna
Receiving frequency of Operation	:	125 kHz

SECTION 3: Test specification, procedures & results

3.1 Test Specification

Test Specification : FCC Part 15 Subpart C
FCC Part 15 final revised on June 26, 2020 and effective July 27, 2020

Title : FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators
Section 15.231 Periodic operation in the band 40.66-40.70 MHz and above 70 MHz.

* Also the EUT complies with FCC Part 15 Subpart B.

3.2 Procedures and results

Item	Test Procedure	Specification	Worst margin	Results	Remarks
Conducted emission	FCC: ANSI C63.10:2013 6 Standard test methods ----- ISED: RSS-Gen 8.8	FCC: Section 15.207 ----- ISED: RSS-Gen 8.8	N/A	N/A	*1)
Automatically Deactivate	FCC: ANSI C63.10:2013 6 Standard test methods ----- ISED: -	FCC: Section 15.231(a)(1) ----- ISED: RSS-210 A1.1	N/A	N/A	Radiated
Electric Field Strength of Fundamental Emission	FCC: ANSI C63.10:2013 6 Standard test methods ----- ISED: RSS-Gen 6.12	FCC: Section 15.231(b) ----- ISED: RSS-210 A1.2	0.9 dB 315 MHz Horizontal PK with Duty Factor	Complied# a)	Radiated
Electric Field Strength of Spurious Emission	FCC: ANSI C63.10:2013 6 Standard test methods ----- ISED: RSS-Gen 6.13	FCC: Section 15.205 Section 15.209 Section 15.231(b) ----- ISED: RSS-210 A1.2 RSS-Gen 8.9	6.2 dB 2835.000 MHz Vertical PK with Duty Factor	Complied a)	Radiated
-20dB Bandwidth	FCC: ANSI C63.10:2013 6 Standard test methods ----- ISED: -	FCC: Section 15.231(c) ----- ISED: Reference data	N/A	Complied b)	Radiated

Note: UL Japan, Inc.'s EMI Work Procedures No. 13-EM-W0420 and 13-EM-W0422.

*1) The test is not applicable since the EUT does not have AC Mains.

a) Refer to APPENDIX 1 (data of Radiated Emission (Electric Field Strength of Fundamental and Spurious Emission))

b) Refer to APPENDIX 1 (data of -20 dB and 99% Occupied Bandwidth)

Symbols:

Complied The data of this test item has enough margin, more than the measurement uncertainty.

Complied# The data of this test item meets the limits unless the measurement uncertainty is taken into consideration.

FCC Part 15.31 (e)

This test was performed with the New Battery (DC 3.0 V) during the tests. Therefore, the EUT complies with the requirement.

FCC Part 15.203 Antenna requirement

It is impossible for end users to replace the antenna, because the antenna is mounted inside of the EUT. Therefore, the equipment complies with the antenna requirement of Section 15.203.

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3.3 Addition to standard

Item	Test Procedure	Specification	Worst margin	Results	Remarks
99 % Occupied Bandwidth	ISED: RSS-Gen 6.7	ISED: RSS-210 A1.3	N/A	-	Radiated

Note: UL Japan, Inc.'s EMI Work Procedures No. 13-EM-W0420 and 13-EM-W0422.

Other than above, no addition, exclusion nor deviation has been made from the standard.

3.4 Uncertainty

There is no applicable rule of uncertainty in this applied standard. Therefore, the following results are derived depending on whether or not laboratory uncertainty is applied.

The following uncertainties have been calculated to provide a confidence level of 95 % using a coverage factor $k = 2$.

Radiated emission

Measurement distance	Frequency range	Uncertainty (+/-)
3 m	9 kHz to 30 MHz	3.3 dB
10 m		3.2 dB
3 m	30 MHz to 200 MHz (Horizontal)	4.8 dB
	(Vertical)	5.0 dB
	200 MHz to 1000 MHz (Horizontal)	5.2 dB
	(Vertical)	6.3 dB
10 m	30 MHz to 200 MHz (Horizontal)	4.8 dB
	(Vertical)	4.8 dB
	200 MHz to 1000 MHz (Horizontal)	5.0 dB
	(Vertical)	5.0 dB
3 m	1 GHz to 6 GHz	4.9 dB
	6 GHz to 18 GHz	5.2 dB
1 m	10 GHz to 26.5 GHz	5.5 dB
	26.5 GHz to 40 GHz	5.5 dB
10 m	1 GHz to 18 GHz	5.2 dB

Antenna Terminal test

Test Item	Uncertainty (+/-)
Automatically Deactivate	0.10 %
-20 dB Emission Bandwidth / 99 % Occupied Bandwidth	0.96 %

3.5 Test Location

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*A2LA Certificate Number: 5107.02 / FCC Test Firm Registration Number: 199967 / ISED Lab Company Number: 2973C

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Test site	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms	Maximum measurement distance
No.1 semi-anechoic chamber	19.2 x 11.2 x 7.7	7.0 x 6.0	No.1 Power source room	10 m
No.2 semi-anechoic chamber	7.5 x 5.8 x 5.2	4.0 x 4.0	-	3 m
No.3 semi-anechoic chamber	12.0 x 8.5 x 5.9	6.8 x 5.75	No.3 Preparation room	3 m
No.3 shielded room	4.0 x 6.0 x 2.7	N/A	-	-
No.4 semi-anechoic chamber	12.0 x 8.5 x 5.9	6.8 x 5.75	No.4 Preparation room	3 m
No.4 shielded room	4.0 x 6.0 x 2.7	N/A	-	-
No.5 semi-anechoic chamber	6.0 x 6.0 x 3.9	6.0 x 6.0	-	-
No.5 measurement room	6.4 x 6.4 x 3.0	6.4 x 6.4	-	-
No.6 shielded room	4.0 x 4.5 x 2.7	4.0 x 4.5	-	-
No.6 measurement room	4.75 x 5.4 x 3.0	4.75 x 4.15	-	-
No.7 shielded room	4.7 x 7.5 x 2.7	4.7 x 7.5	-	-
No.8 measurement room	3.1 x 5.0 x 2.7	3.1 x 5.0	-	-
No.9 measurement room	8.8 x 4.6 x 2.8	2.4 x 2.4	-	-
No.11 measurement room	6.2 x 4.7 x 3.0	4.8 x 4.6	-	-

* Size of vertical conducting plane (for Conducted Emission test) : 2.0 x 2.0 m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

3.6 Test data, Test instruments, and Test set up

Refer to APPENDIX.

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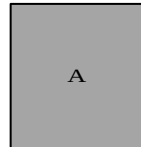
SECTION 4: Operation of EUT during testing

4.1 Operating Mode(s)

Test Item*	Mode
Automatically Deactivate Duty Cycle	Normal use mode
Electric Field Strength of Fundamental Emission Electric Field Strength of Spurious Emission -20 dB & 99 % Occupied Bandwidth	Transmitting mode (Tx) *1)
* The system was configured in typical fashion (as a user would normally use it) for testing. *1) The software of this mode is the same as one of normal product, except that EUT continues to transmit when transmitter button is being pressed (For Normal use mode, EUT stops to transmit in a given time, even if transceiver button is being pressed.) * EUT was set by the software as follows; Software: Ver.50.4 (Date: 2020.7.29, Storage location: location: EUT memory) *This setting of software is the worst case. Any conditions under the normal use do not exceed the condition of setting. In addition, end users cannot change the settings of the output power of the product.	

Justification: The system was configured in typical fashion (as a user would normally use it) for testing.

4.2 Configuration and peripherals



* Setup was taken into consideration and test data was taken under worse case conditions.

Description of EUT

No.	Item	Model number	Serial number	Manufacturer	Remarks
A	Keyless Operation Key (FOB)	G8D-744M-KEY-N	97F21B72 *1) 93F21B72 *2)	NIDEC MOBILITY CORPORATION	EUT

*1) Used for Normal use mode

*2) Used for Transmitting mode

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SECTION 5: Radiated emission (Electric Field Strength of Fundamental and Spurious Emission)

Test Procedure and conditions

[For below 30 MHz]

The noise level was checked by moving a search-coil (Loop Antenna) close to the EUT.

[For 30 MHz to 1 GHz]

EUT was placed on a urethane platform of nominal size, 0.5 m by 1.0 m, raised 0.8 m above the conducting ground plane. The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with a ground plane.

[For above 1 GHz]

EUT was placed on a urethane platform of nominal size, 0.5 m by 0.5 m, raised 1.5 m above the conducting ground plane. The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with absorbent materials lined on a ground plane.

The measuring antenna height was varied between 1 and 4 m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field strength.

Test antenna was aimed at the EUT for receiving the maximum signal and always kept within the illumination area of the 3 dB beamwidth of the antenna.

The measurements were performed for both vertical and horizontal antenna polarization.

The radiated emission measurements were made with the following detector function of the test receiver / spectrum analyzer.

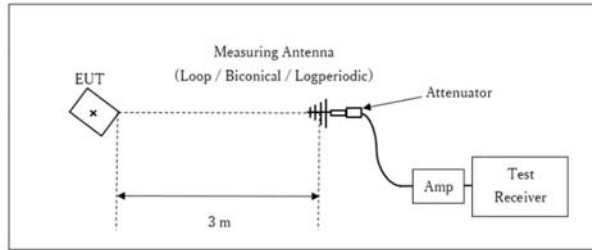
Test Antennas are used as below;

Frequency	Below 30 MHz	30 MHz to 200 MHz	200 MHz to 1 GHz	Above 1 GHz
Antenna Type	Loop	Biconical	Logperiodic	Horn

	From 9 kHz to 90 kHz and From 110 kHz to 150 kHz	From 90 kHz to 110 kHz	From 150 kHz to 490 kHz	From 490 kHz to 30 MHz	From 30 MHz to 1 GHz	Above 1 GHz
Detector Type	Peak	Peak	Peak	Peak	Peak and Peak with Duty factor	Peak and Peak with Duty factor
IF Bandwidth	200 Hz	200 Hz	9.1 kHz	9.1 kHz	120 kHz	PK: S/A: RBW 1 MHz, VBW: 3 MHz

[Test Setup]

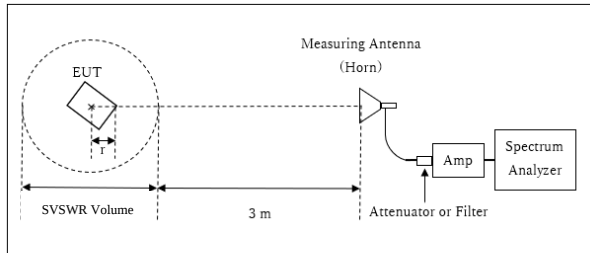
Below 1 GHz



x : Center of turn table

Test Distance: 3 m

1 GHz - 10 GHz



r : Radius of an outer periphery of EUT

x : Center of turn table

Distance Factor: $20 \times \log(4.0 \text{ m}^*/3.0 \text{ m}) = 2.5 \text{ dB}$

* Test Distance: $(3 + \text{SVSWR Volume} / 2) - r = 4.0 \text{ m}$

SVSWR Volume: 2.0 m

(SVSWR Volume has been calibrated based on CISPR 16-1-4.)

$r = 0.0 \text{ m}$

* The test was performed with $r = 0.0 \text{ m}$ since EUT is small and it was the rather conservative condition.

- The carrier level (or, noise levels) was (or were) measured at each position of all three axes X, Y and Z, and the position that has the maximum noise was determined.

Noise levels of all the frequencies were measured at the position.

This EUT has two modes which mechanical key is inserted or not. The worst case was confirmed with and without mechanical key, as a result, the test without mechanical key was the worst case. Therefore, the test without mechanical key was performed only.

*The result is rounded off to the second decimal place, so some differences might be observed.

Measurement range	: 9 kHz - 3.2 GHz
Test data	: APPENDIX
Test result	: Pass

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SECTION 6: Automatically deactivate

Test Procedure

The measurement was performed with Electric field strength using a spectrum analyzer.

Test data : APPENDIX

Test result : Pass

SECTION 7: -20 dB and 99 % Occupied Bandwidth

Test Procedure

The test was measured with a spectrum analyzer using a test fixture.

Test	Span	RBW	VBW	Sweep	Detector	Trace	Instrument used
20 dB Bandwidth	500 kHz	5.1 kHz	16 kHz	Auto	Peak	Max Hold	Spectrum Analyzer
99 % Occupied Bandwidth	Enough width to display emission skirts	1 to 5 % of OBW	Three times of RBW	Auto	Peak *1)	Max Hold *1)	Spectrum Analyzer
*1) The measurement was performed with Peak detector, Max Hold since the duty cycle was not 100 %. Peak hold was applied as Worst-case measurement.							

Test data : APPENDIX

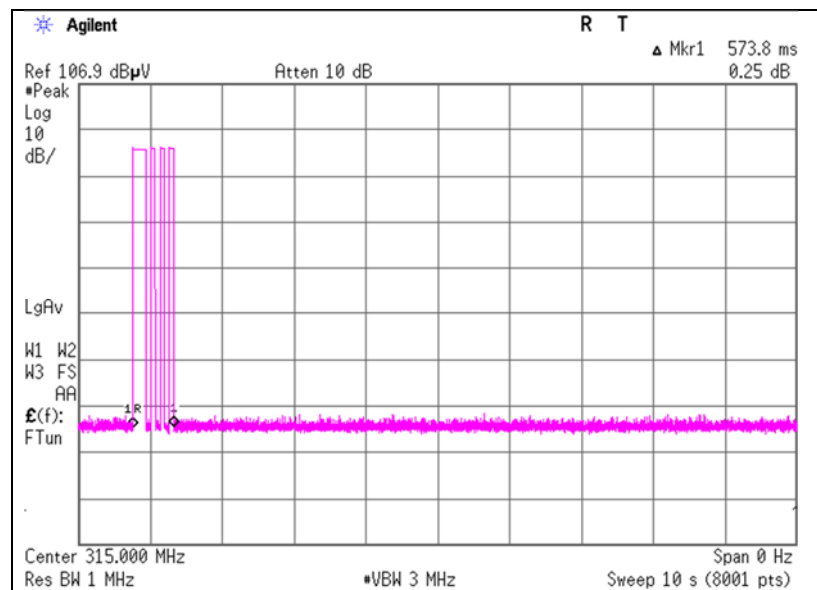
Test result : Pass

APPENDIX 1: Test data

Automatically deactivate

Report No.	13440383H
Test place	Ise EMC Lab.
Semi Anechoic Chamber	No.4
Date	July 29, 2020
Temperature / Humidity	22 deg. C / 77 % RH
Engineer	Akihiko Maeda
Mode	Tx 315 MHz

Time of Transmitting [sec]	Limit [sec]	Result
0.5738	5.00	Pass



* The EUT transmits UHF when LF signal is received from a car or a button on the EUT is pressed. In both cases, the UHF transmission is stopped within 5 seconds. So the test was performed by a button-pressed operation as the worst case. Please refer to the "Theory of operation".

Radiated Emission (Electric Field Strength of Fundamental and Spurious Emission)

Report No. 13440383H
Test place Ise EMC Lab.
Semi Anechoic Chamber No.4
Date July 29, 2020
Temperature / Humidity 22 deg. C / 77 % RH
Engineer Akihiko Maeda
Mode Tx 315 MHz

QP or PK

Frequency [MHz]	Detector	Reading [dBuV]		Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]		Limit dBuV/m	Margin [dB]		Remark Inside or Outside of Restricted Bands
		Hor	Ver					Hor	Ver		Hor	Ver	
315.000	PK	82.7	78.8	13.9	9.8	31.8	-	74.7	70.8	95.6	20.9	24.8	Carrier
630.000	PK	29.4	28.9	19.3	11.6	32.0	-	28.3	27.8	75.6	47.3	47.8	Outside
945.000	PK	32.9	30.9	21.9	13.0	30.9	-	36.9	34.9	75.6	38.7	40.7	Outside
1260.000	PK	46.6	46.3	25.3	6.1	34.0	-	44.0	43.7	75.6	31.7	32.0	Outside
1575.000	PK	44.1	42.8	25.0	5.5	33.2	-	41.4	40.1	73.9	32.5	33.8	Inside
1890.000	PK	43.3	43.3	25.5	5.5	32.3	-	41.9	41.9	75.6	33.7	33.7	Outside
2205.000	PK	41.8	41.5	28.2	5.6	32.0	-	43.6	43.3	73.9	30.3	30.6	Inside
2520.000	PK	44.3	42.8	27.7	5.7	31.8	-	45.8	44.3	75.6	29.8	31.3	Outside
2835.000	PK	44.5	45.1	28.5	5.8	31.7	-	47.1	47.7	73.9	26.8	26.2	Inside
3150.000	PK	42.0	42.5	28.8	5.9	31.6	-	45.1	45.6	75.6	30.5	30.0	Outside

PK with Duty factor

Frequency [MHz]	Detector	Reading [dBuV]		Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]		Limit dBuV/m	Margin [dB]		Remark
		Hor	Ver					Hor	Ver		Hor	Ver	
315.000	PK	82.7	78.8	13.9	9.8	31.8	0.0	74.7	70.8	75.6	0.9	4.8	Carrier
630.000	PK	29.4	28.9	19.3	11.6	32.0	0.0	28.3	27.8	55.6	27.3	27.8	Outside
945.000	PK	32.9	30.9	21.9	13.0	30.9	0.0	36.9	34.9	55.6	18.7	20.7	Outside
1260.000	PK	46.6	46.3	25.3	6.1	34.0	0.0	44.0	43.7	55.6	11.7	12.0	Outside
1575.000	PK	44.1	42.8	25.0	5.5	33.2	0.0	41.4	40.1	53.9	12.5	13.8	Inside
1890.000	PK	43.3	43.3	25.5	5.5	32.3	0.0	41.9	41.9	55.6	13.7	13.7	Outside
2205.000	PK	41.8	41.5	28.2	5.6	32.0	0.0	43.6	43.3	53.9	10.3	10.6	Inside
2520.000	PK	44.3	42.8	27.7	5.7	31.8	0.0	45.8	44.3	55.6	9.8	11.3	Outside
2835.000	PK	44.5	45.1	28.5	5.8	31.7	0.0	47.1	47.7	53.9	6.8	6.2	Inside
3150.000	PK	42.0	42.5	28.8	5.9	31.6	0.0	45.1	45.6	55.6	10.5	10.0	Outside

Sample calculation:

Result of PK = Reading + Ant Factor + Loss {Cable + Attenuator + Filter (above 1GHz) +Distance factor (above 1 GHz)} - Gain (Amplifier)

Result of PK with Duty factor = Reading + Ant Factor + Loss {Cable + Attenuator + Filter (above 1 GHz) +Distance factor (above 1 GHz)} - Gain (Amplifier) + Duty factor

For above 1GHz : Distance Factor: $20 \times \log(4.0 \text{ m}/3.0 \text{ m}) = 2.50 \text{ dB}$

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

Since the peak emission result satisfied the average limit, duty factor was omitted.

Although Duty of this product was 100% or less, the result of AV (PK with Duty factor) was calculated by applying Duty 100% as worst.

UL Japan, Inc.

Ise EMC Lab.

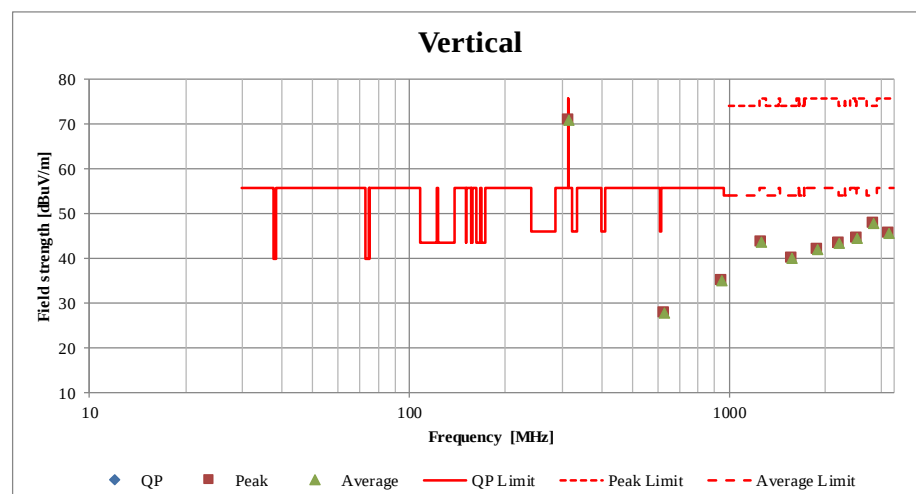
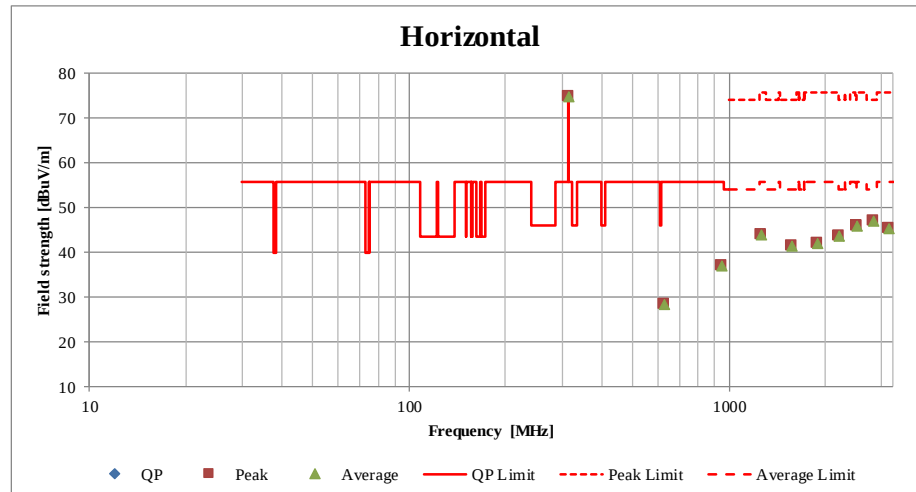
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Radiated Spurious Emission (Plot data, Worst case)

Report No. 13440383H
Test place Ise EMC Lab.
Semi Anechoic Chamber No.4
Date July 29, 2020
Temperature / Humidity 22 deg. C / 77 % RH
Engineer Akihiko Maeda
Mode Tx 315 MHz



*These plots data contains sufficient number to show the trend of characteristic features for EUT.

-20 dB and 99% Occupied Bandwidth

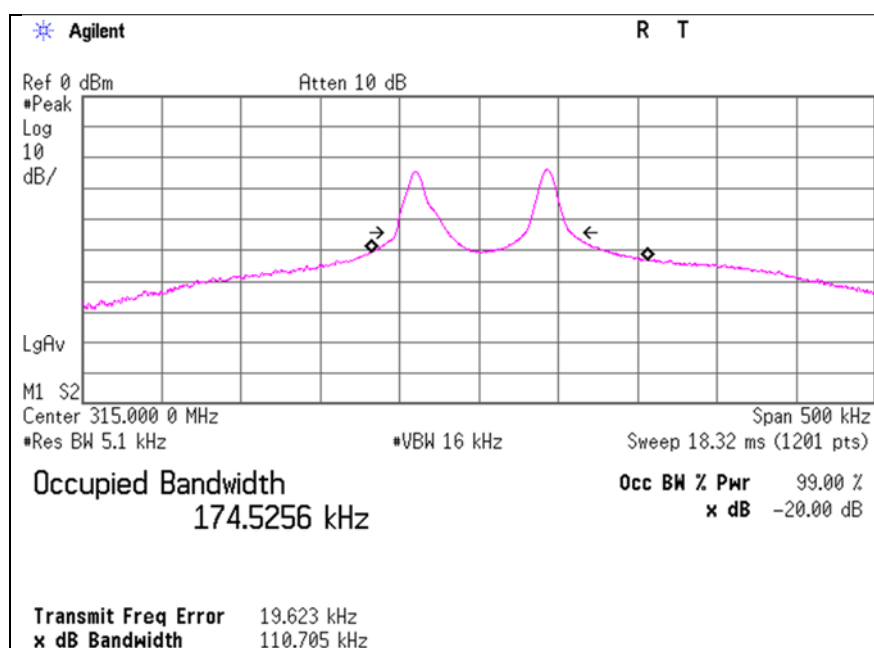
Report No.	13440383H
Test place	Ise EMC Lab.
Semi Anechoic Chamber	No.4
Date	July 29, 2020
Temperature / Humidity	22 deg. C / 77 % RH
Engineer	Akihiko Maeda
Mode	Tx 315 MHz

Bandwidth Limit : Fundamental Frequency **315.00** MHz x 0.25% = 787.50 kHz

* The above limit was calculated from more stringent nominal frequency.

-20dB Bandwidth [kHz]	Bandwidth Limit [kHz]	Result
110.705	787.50	Pass

99% Occupied Bandwidth [kHz]	Bandwidth Limit [kHz]	Result
174.5256	787.50	Pass



APPENDIX 2: Test instruments

Test equipment

Test Item	Local ID	LIMS ID	Description	Manufacturer	Model	Serial	Last Calibration Date	Cal Int
RE	MAEC-04	142011	AC4_Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 3m	DA-10005	05/25/2020	24
RE	MOS-15	141562	Thermo-Hygrometer	CUSTOM. Inc	CTH-201	0010	01/07/2020	12
RE	MMM-10	141545	DIGITAL HiTESTER	Hioki	3805	51201148	01/06/2020	12
RE	MJM-26	142227	Measure	KOMELON	KMC-36	-	-	-
RE	COTS-ME MI-02	178648	EMI measurement program	TSJ (Techno Science Japan)	TEPTO-DV	-	-	-
RE	MAEC-04-SVSWR	142017	AC4_Semi Anechoic Chamber(SVSWR)	TDK	Semi Anechoic Chamber 3m	DA-10005	04/04/2019	24
RE	MAT-34	141331	Attenuator(6dB)	TME	UFA-01	-	02/05/2020	12
RE	MBA-05	141425	Biconical Antenna	Schwarzbeck Mess - Elektronik	VHA9103+BBA9106	1302	08/24/2019	12
RE	MCC-50	141397	Coaxial Cable	UL Japan	-	-	03/24/2020	12
RE	MLA-23	141267	Logperiodic Antenna(200-1000MHz)	Schwarzbeck Mess - Elektronik	VUSLP9111B	9111B-192	08/24/2019	12
RE	MPA-14	141583	Pre Amplifier	SONOMA INSTRUMENT	310	260833	02/18/2020	12
RE	MHA-21	141508	Horn Antenna 1-18GHz	Schwarzbeck Mess - Elektronik	BBHA9120D	557	05/22/2020	12
RE	MPA-12	141581	MicroWave System Amplifier	Keysight Technologies Inc	83017A	650	10/16/2019	12
RE	MCC-246	199563	Microwave Cable	HUBER+SUNER	SF126E/11PC35/11PC35/1000M,5000M	537061/126E / 537072/126E	06/11/2020	12
RE	MHF-27	141297	High Pass Filter(1.1-10GHz)	TOKYO KEIKI	TF219CD1	1001	01/09/2020	12
RE	MLPA-07	142645	Loop Antenna	UL Japan	-	-	-	-

***Hyphens for Last Calibration Date and Cal Int (month) are instruments that Calibration is not required (e.g. software), or instruments checked in advance before use.**

The expiration date of the calibration is the end of the expired month.

As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chains of calibrations.

All equipment is calibrated with valid calibrations. Each measurement data is traceable to the national or international standards.

Test item:

RE: Radiated emission, 99 % Occupied Bandwidth, -20 dB bandwidth, Automatically deactivate and Duty cycle tests

UL Japan, Inc.

Ise EMC Lab.

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